Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,822	YAMADA, TAKAHIRO	
Examiner	Art Unit	
Anh T.N. Vo	2861	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	20	1/20/2006	AV
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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